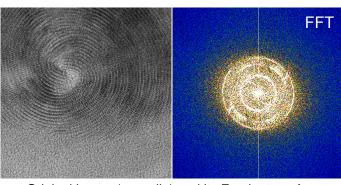
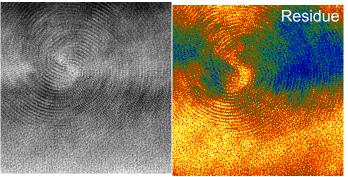
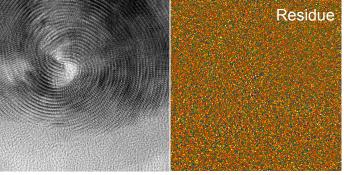
Filters



Original image (crysotile) and its Fourier transform



Radial background Wiener filtered image and its residue



Local 2D background Wiener filtered image and its residue

HREM-Filters Pro/Lite

Optimal Noise Filters for high-Resolution Electron Microscopy

HREM-Filters are sophisticated Wiener and Difference filters that works even for non-ideal crystals, such as a nano-crystal or cylindrical crystal.

HREM-Filters Lite can be downloaded free of charge from our web site: www.hremresearch.com.

Key Features

- Uses smoothed two-dimensional background [2].
- Uses locally estimated backgrounds [3].
- Trend-subtraction
- Optimal periodic Wiener filter using accurate base vectors.

(middle row) Wiener filter based on a radial background [1] does not work for a crysotile image, and substantial features are left behind in the residue.

(bottom row) Wiener filter based on local twodimensional backgrounds extracts all the structure information, and the residue (a difference between the filtered and original images) is featureless.

References:

[1] R. Kilaas, J. Microscopy 190 (1997) 45-51.

[2] P.H.C. Eilers et al, *Computational Statistics and Data Analysis* 50 (2006) 61-76.

[3] T. Kogure, P.H.C. Eilers and K. Ishizuka, *Microscopy and Analysis* 22 Nov. (2008) S11-S14.

Credits: Crysotile image courtesy of Prof. Toshihiro Kogure.

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